

September 2006

FDP8860

N-Channel PowerTrench® MOSFET

30V, **80A**, **2.5m** Ω

Features

- Max $r_{DS(on)}$ = 2.5m Ω at V_{GS} = 10V, I_D = 80A
- Max $r_{DS(on)}$ = 2.9m Ω at V_{GS} = 4.5V, I_D = 80A
- Low Miller Charge
- Low Q_{rr} Body Diode
- UIL Capability (Single Pulse and Repetitive Pulse)
- RoHS Compliant

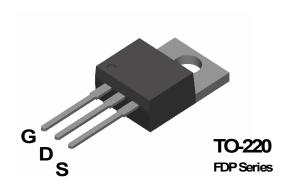


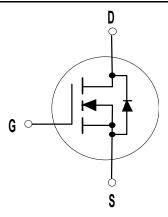
General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, low $r_{DS(on)}$ and fast switching speed.

Application

- DC DC Conversion
- Start / Alternator Sytems





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

| Symbol | Parameter | | Ratings | Units |
|-----------------------------------|---|----------|-------------|-------|
| V _{DS} | Drain to Source Voltage | | 30 | V |
| V _{GS} | Gate to Source Voltage | | ±20 | V |
| | Drain Current -Continuous (Package limited) T _C = 25°C | | 80 | |
| I_D | -Continuous (Silicon limited) T _C = 25°C | | 219 | Α |
| | -Pulsed | (Note 1) | 556 | |
| E _{AS} | Single Pulse Avalanche Energy | (Note 2) | 673 | mJ |
| P _D | Power Dissipation | | 254 | W |
| T _J , T _{STG} | Operating and Storage Temperature | | -55 to +175 | °C |

Thermal Characteristics

| $R_{\theta JC}$ | Thermal Resistance, Junction to Case TO220 | 0.59 | °C/W |
|-----------------|---|------|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient TO220 | 62 | C/VV |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|---------|---------|-----------|------------|----------|
| FDP8860 | FDP8860 | TO220AB | Tube | N/A | 50 units |

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Тур | Max | Units |
|--|--|---|-----|-----|----------|-------|
| Off Chara | acteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 1mA$, $V_{GS} = 0V$ | 30 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_{J}}$ | Breakdown Voltage Temperature Coefficient | I _D = 1mA, referenced to 25°C | | 22 | | mV/°C |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 24V,$ $V_{GS} = 0V$ $T_{J} = 150^{\circ}C$ | | | 1 250 | μА |
| I _{GSS} | Gate to Source Leakage Current | V _{GS} = ±20V | | | ±100 | nA |

On Characteristics

| $V_{GS(th)}$ | Gate to Source Threshold Voltage | $V_{GS} = V_{DS}, I_D = 250 \mu A$ | 1 | 1.6 | 2.5 | V |
|--|--|---|---|------|-----|-------|
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate to Source Threshold Voltage Temperature Coefficient | I _D = 250μA, referenced to 25°C | | -9.6 | | mV/°C |
| | Desire to Course On Desiretores | $V_{GS} = 10V, I_D = 80A$ | | 1.9 | 2.5 | 0 |
| _ | | $V_{GS} = 5V, I_D = 80A$ | | 2.0 | 2.8 | |
| r _{DS(on)} | Drain to Source On Resistance | $V_{GS} = 4.5V, I_D = 80A$ | | 2.1 | 2.9 | mΩ |
| | | $V_{GS} = 10V$, $I_D = 80A$, $T_J = 150$ °C | | 2.9 | 3.8 | |
| 9 _{FS} | Forward Transconductance | V _{DS} = 10V, I _D = 80A | | 3.4 | | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V = 45V V = 0V | 9200 | 12240 | pF |
|------------------|------------------------------|--|------|-------|----|
| C _{oss} | Output Capacitance | V _{DS} = 15V, V _{GS} = 0V, f = 1MHz | 1700 | 2260 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 11/11/2 | 1060 | 1590 | pF |
| R_q | Gate Resistance | f = 1MHz | 1.7 | | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | 35 | 56 | ns |
|---------------------|-------------------------------|---|-----|-----|----|
| t _r | Rise Time | $V_{DD} = 15V, I_{D} = 80A$ $V_{GS} = 5V, R_{GEN} = 3\Omega$ | 135 | 216 | ns |
| t _{d(off)} | Turn-Off Delay Time | V _{GS} = 5V, K _{GEN} = 3Ω | 64 | 103 | ns |
| t _f | Fall Time | | 59 | 95 | ns |
| $Q_{g(TOT)}$ | Total Gate Charge at 10V | V _{GS} = 0V to 10V | 158 | 222 | nC |
| $Q_{g(5)}$ | Total Gate Charge at 5V | $V_{GS} = 0V \text{ to } 5V$ $V_{DD} = 15V$ $I_{D} = 80A$ | 81 | 114 | nC |
| Q _{gs} | Gate to Source Gate Charge | ID - 60A | 27 | | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | | 33 | | nC |

Drain-Source Diode Characteristics

| V | Source to Drain Diode Forward Voltage | V _{GS} = 0V, I _S = 80A | | 0.88 | 1.25 | \/ |
|-----------------|--|--|--|------|------|----|
| V_{SD} | Source to Drain blode 1 ofward voltage | $V_{GS} = 0V, I_{S} = 40A$ | | 0.81 | 1.2 | v |
| t _{rr} | Reverse Recovery Time | I _F = 80A, di/dt = 100A/μs | | 60 | 90 | ns |
| Q _{rr} | Reverse Recovery Charge | 1F - 80A, αναι - 100Α/μS | | 74 | 111 | nC |

Notes:
1: Pulse Test: Pulse Width < 80μs, Duty cycle < 0.5%.
2: Starting T_J =25°C, L= 0.3mH, I_{AS} = 67A,V_{DD} = 27V, V_{GS} = 10V.

Typical Characteristics T_J = 25°C unless otherwise noted

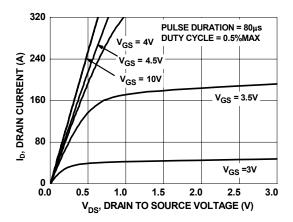


Figure 1. On Region Characteristics

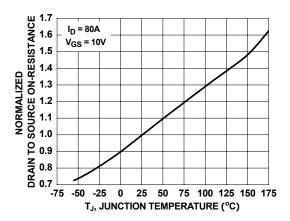


Figure 3. Normalized On Resistance vs Junction Temperature

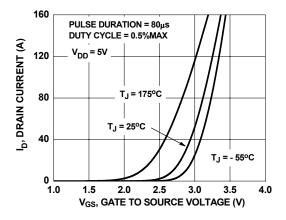


Figure 5. Transfer Characteristics

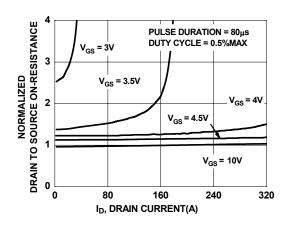


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

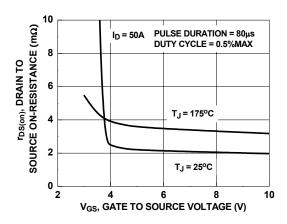


Figure 4. On-Resistance vs Gate to Source Voltage

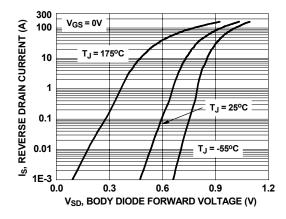


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics T_J = 25°C unless otherwise noted

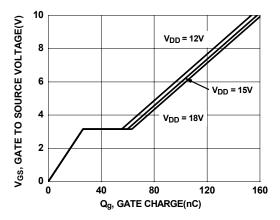


Figure 7. Gate Charge Characteristics

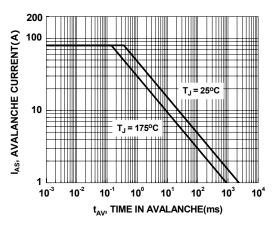


Figure 9. Unclamped Inductive Switching Capability

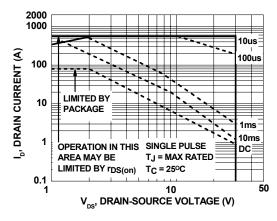


Figure 11. Forward Bias Safe Operating Area

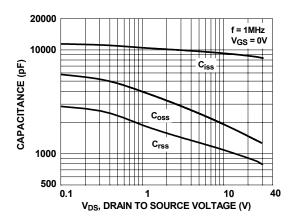


Figure 8. Capacitance vs Drain to Source Voltage

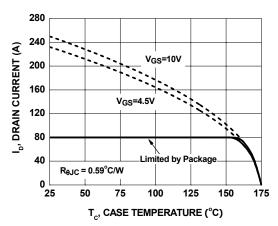


Figure 10. Maximum Continuous Drain Current vs Case Temperature

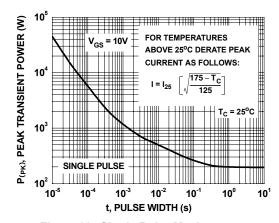


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics T_J = 25°C unless otherwise noted

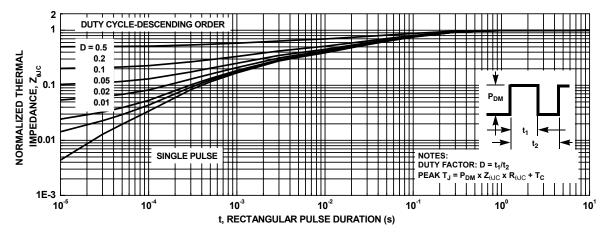


Figure 13. Transient Thermal Response Curve

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Rev. 120